# International **T©R** Rectifier

#### DIGITAL AUDIO MOSFET

# IRF6665PbF

#### Features

- Latest MOSFET Silicon technology
- Key parameters optimized for Class-D audio amplifier applications
- Low R<sub>DS(on)</sub> for improved efficiency
- $\bullet$  Low  $\mathsf{Q}_\mathsf{g}$  for better THD and improved efficiency
- $\bullet$  Low  $\tilde{Q_{rr}}$  for better THD and lower EMI
- Low package stray inductance for reduced ringing and lower EMI
- Can deliver up to 100W per channel into  $8\Omega$  with no heatsink @
- Dual sided cooling compatible
- · Compatible with existing surface mount technologies
- RoHS compliant containing no lead or bromide
- •Lead-Free (Qualified up to 260°C Reflow)

Key Parameters							
V <sub>DS</sub>	100	V					
R <sub>DS(on)</sub> typ. @ V <sub>GS</sub> = 10V	53	mΩ					
Q <sub>g</sub> typ.	8.7	nC					
R <sub>G(int)</sub> typ.	1.9	Ω					





Applicable DirectFET Outline and Substrate Outline (see p. 6, 7 for details)

					-	-			
SQ	SX	ST	SH	MQ	MX	МТ	MN		

#### Description

This Digital Audio MOSFET is specifically designed for Class-D audio amplifier applications. This MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area. Furthermore, gate charge, body-diode reverse recovery and internal gate resistance are optimized to improve key Class-D audio amplifier performance factors such as efficiency, THD, and EMI.

The IRF6665PbF device utilizes DirectFET<sup>™</sup> packaging technology. DirectFET<sup>™</sup> packaging technology offers lower parasitic inductance and resistance when compared to conventional wirebonded SOIC packaging. Lower inductance improves EMI performance by reducing the voltage ringing that accompanies fast current transients. The DirectFET<sup>™</sup> package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing method and processes. The DirectFET<sup>™</sup> package also allows dual sided cooling to maximize thermal transfer in power systems, improving thermal resistance and power dissipation. These features combine to make this MOSFET a highly efficient, robust and reliable device for Class-D audio amplifier applications.

#### **Absolute Maximum Ratings**

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	100	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	19	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	4.2	А
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	3.4	
I <sub>DM</sub>	Pulsed Drain Current ①	34	
$P_{D} @ T_{C} = 25^{\circ}C$	Maximum Power Dissipation	42	W
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation 3	2.2	]
P <sub>D</sub> @T <sub>A</sub> = 70°C	Power Dissipation 3	1.4	
	Linear Derating Factor	0.017	W/°C
TJ	Operating Junction and	-40 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		

#### **Thermal Resistance**

	Parameter	Тур.	Max.	Units
$R_{ heta JA}$	Junction-to-Ambient 39		58	°C/W
R <sub>0JA</sub>	Junction-to-Ambient 69	12.5		
R <sub>0JA</sub>	Junction-to-Ambient ⑦ ⑨	20		
R <sub>0JC</sub>	Junction-to-Case ® 9		3.0	
R <sub>0J-PCB</sub>	Junction-to-PCB Mounted	1.4		

#### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_{D} = 250 \mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.12		V/°C	Reference to 25°C, $I_D = 1mA$
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		53	62	mΩ	$V_{GS} = 10V, I_{D} = 5.0A$ (4)
V <sub>GS(th)</sub>	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 100V, V_{GS} = 0V$
				250		$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -20V
R <sub>G(int)</sub>	Internal Gate Resistance		1.9	2.9	Ω	

#### Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	6.6			S	$V_{DS} = 10V, I_{D} = 5.0A$
Q <sub>g</sub>	Total Gate Charge		8.4	13		$V_{DS} = 50V$
Q <sub>gs1</sub>	Pre-Vth Gate-to-Source Charge		2.2			$V_{GS} = 10V$
Q <sub>gs2</sub>	Post-Vth Gate-to-Source Charge		0.64		1	$I_D = 5.0A$
Q <sub>gd</sub>	Gate-to-Drain Charge		2.8		nC	See Fig. 6 and 17
Q <sub>godr</sub>	Gate Charge Overdrive		2.8		1	
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		3.4		1	
t <sub>d(on)</sub>	Turn-On Delay Time		7.4			$V_{DD} = 50V$
t <sub>r</sub>	Rise Time		2.8			I <sub>D</sub> = 5.0A
t <sub>d(off)</sub>	Turn-Off Delay Time		14		ns	$R_{G} = 6.0\Omega$
t <sub>f</sub>	Fall Time		4.3			V <sub>GS</sub> = 10V ④
C <sub>iss</sub>	Input Capacitance		530			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		110		1	$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		29		pF	f = 1.0 MHz
C <sub>oss</sub>	Output Capacitance		510		1	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C <sub>oss</sub>	Output Capacitance		67		1	$V_{GS} = 0V, V_{DS} = 80V, f = 1.0MHz$
Coss eff.	Effective Output Capacitance		130		]	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $

#### **Avalanche Characteristics**

	Parameter	Тур.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy@		11	mJ
I <sub>AR</sub>	Avalanche Current ①	_	5.0	А

#### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			38		MOSFET symbol
	(Body Diode)				Α	showing the
I <sub>SM</sub>	Pulsed Source Current		_	34		integral reverse
	(Body Diode) ①					p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage	_		1.3	V	$T_{J} = 25^{\circ}C, I_{S} = 5.0A, V_{GS} = 0V @$
t <sub>rr</sub>	Reverse Recovery Time		31		ns	$T_J = 25^{\circ}C, I_F = 5.0A, V_{DD} = 25V$
Q <sub>rr</sub>	Reverse Recovery Charge		37		nC	di/dt = 100A/µs ④

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- 0 Starting  $T_J$  = 25°C, L = 0.89mH,  $R_G$  = 25 $\Omega,~I_{AS}$  = 5.0A.
- ③ Surface mounted on 1 in. square Cu board.
- ④ Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- ⑤ C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- $\ensuremath{\textcircled{}^{\circ}}$  Used double sided cooling , mounting pad.
- ⑦ Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- $\ensuremath{\circledast}$  T\_C measured with thermal couple mounted to top (Drain) of part.
- $\circledast~R_{\theta}$  is measured at  $T_{J}$  of approximately 90°C.
- Image Based on testing done using a typical device & evaluation board at Vbus=±45V, f<sub>SW</sub>=400KHz, and T<sub>A</sub>=25°C. The delta case temperature  $\Delta T_C$  is 55°C.

#### International IOR Rectifier 100 VGS 15V 10V TOP 9.0V b, Drain-to-Source Current (A) 8.0V 7.0V BOTTOM 6.0V 10 1 ≤60µs PULSE WIDTH Tj = 25°C 0.1 0.1 1 10 100 1000 V<sub>DS</sub>, Drain-to-Source Voltage (V)

Fig 1. Typical Output Characteristics



Fig 3. Typical Transfer Characteristics



V<sub>DS</sub>, Drain-to-Source Voltage (V) **Fig 5.** Typical Capacitance vs.Drain-to-Source Voltage www.irf.com

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Fig 4. Normalized On-Resistance vs. Temperature



Fig 6. Typical Gate Charge vs.Gate-to-Source Voltage

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Fig 7. Typical Source-Drain Diode Forward Voltage



Fig 9. Maximum Drain Current vs. Ambient Temperature





Fig 10. Threshold Voltage vs. Temperature



Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient ③

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Fig 15a. Unclamped Inductive Test Circuit



Fig 15b. Unclamped Inductive Waveforms



Fig 16a. Switching Time Test Circuit www.irf.com



Fig 13. On-Resistance vs. Drain Current



Fig 14. Maximum Avalanche Energy vs. Drain Current



Fig 16b. Switching Time Waveforms

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\* V<sub>GS</sub> = 5V for Logic Level Devices

Fig 18. Diode Reverse Recovery Test Circuit for N-Channel HEXFET<sup>®</sup> Power MOSFETs

## DirectFET<sup>™</sup> Substrate and PCB Layout, SH Outline

## (Small Size Can, H-Designation).

Please see DirectFET application note AN-1035 for all details regarding PCB assembly using DirectFET. This includes all recommendations for stencil and substrate designs.





## DirectFET™ Outline Dimension, SH Outline

(Small Size Can, H-Designation).

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### DirectFET™ Part Marking



## DirectFET<sup>™</sup> Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as IRF6665TRPBF). For 1000 parts on 7" reel, order IRF6665TR1PBF

	REEL DIMENSIONS								
S	STANDARD OPTION (QTY 4800)					1 OPTION	I (QTY 10	00)	
	ME	TRIC	IMP	ERIAL	ME	TRIC	IMPERIAL		
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
A	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C	
В	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C	
С	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50	
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C	
E	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C	
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53	
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C	
Н	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C	

Loaded Tape Feed Direction



DIMENSIONS							
	ME	TRIC	IMPERIAL				
CODE	MIN	MAX	MIN	MAX			
Α	7.90	8.10	0.311	0.319			
В	3.90	4.10	0.154	0.161			
С	11.90	12.30	0.469	0.484			
D	5.45	5.55	0.215	0.219			
E	4.00	4.20	0.158	0.165			
F	5.00	5.20	0.197	0.205			
G	1.50	N.C	0.059	N.C			
Н	1.50	1.60	0.059	0.063			

Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualification Standards can be found on IR's Web site.



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9

Note: For the most current drawings please refer to the IR website at: <u>http://www.irf.com/package/</u>